## Search Notes



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Applicant(s)/Patent Under Reexamination

SCHULTZ, JUERGEN

Examiner

Art Unit

DEVONA E FAULK

2615

## SEARCHED

Class	Subclass	Date	Examiner
381	86,91,92	2/3/06	DEF
381	86,91,92	4/9/2008	DEF
381	86,91,92,111,122	6/7,7/091	DEF

## SEARCH NOTES

Search Notes	Date	Examiner
Assignee/Inventor search	2/3/07	DEF
Reviewed art submitted on IDS	2/3/07	DEF
Additional search	10/18/07	DEF
Reviewed applicant's arguments/maintained rejection	4/9/2008	DEF
additional search	6/7,17/09	DEF

## INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

/DEVONA E FAULK/ Primary Examiner.Art Unit 2614

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